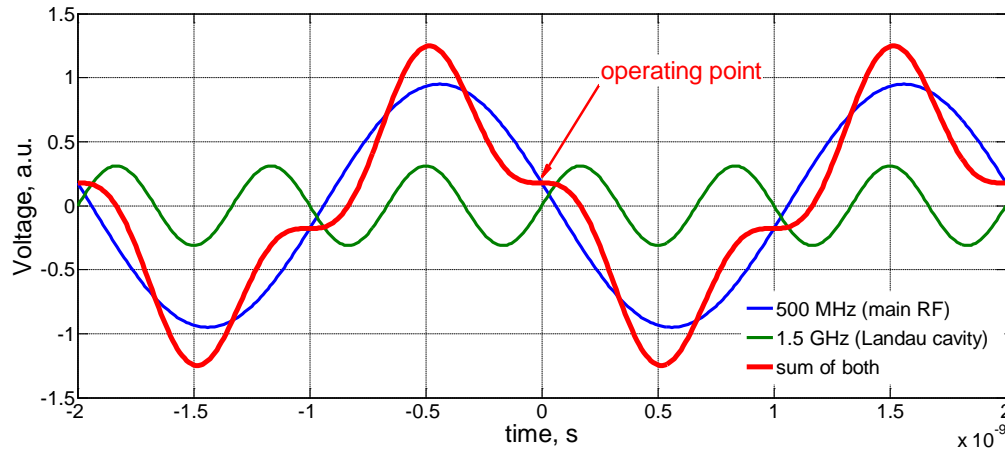




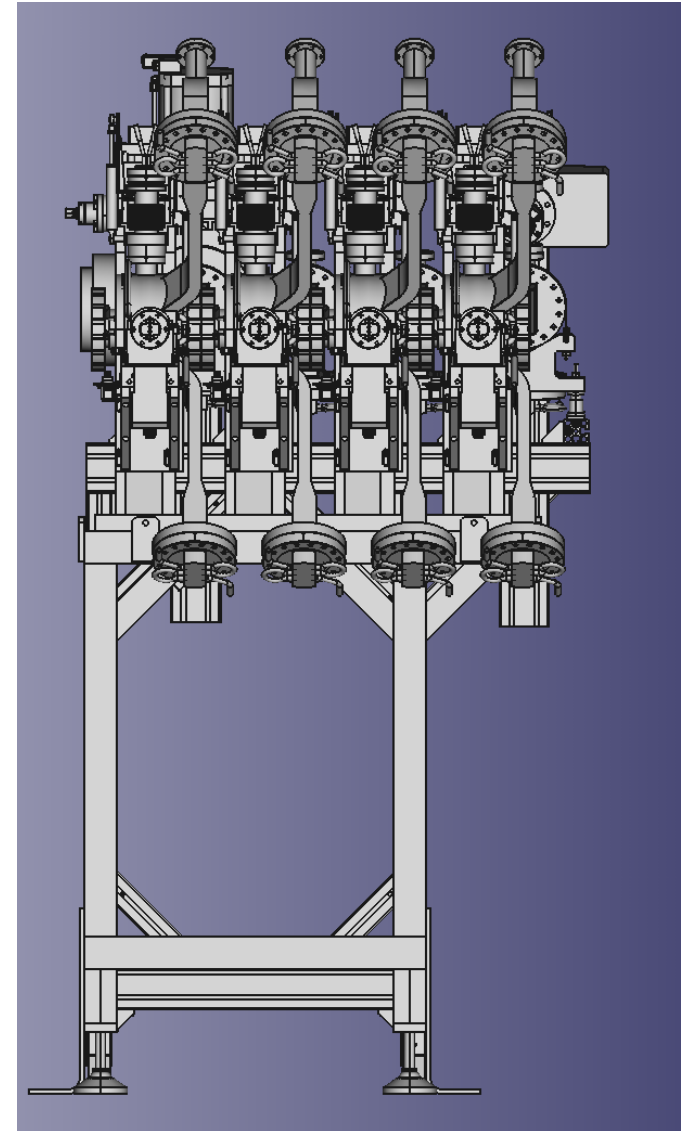
BESSY II

Transient beam loading with harmonic RF systems

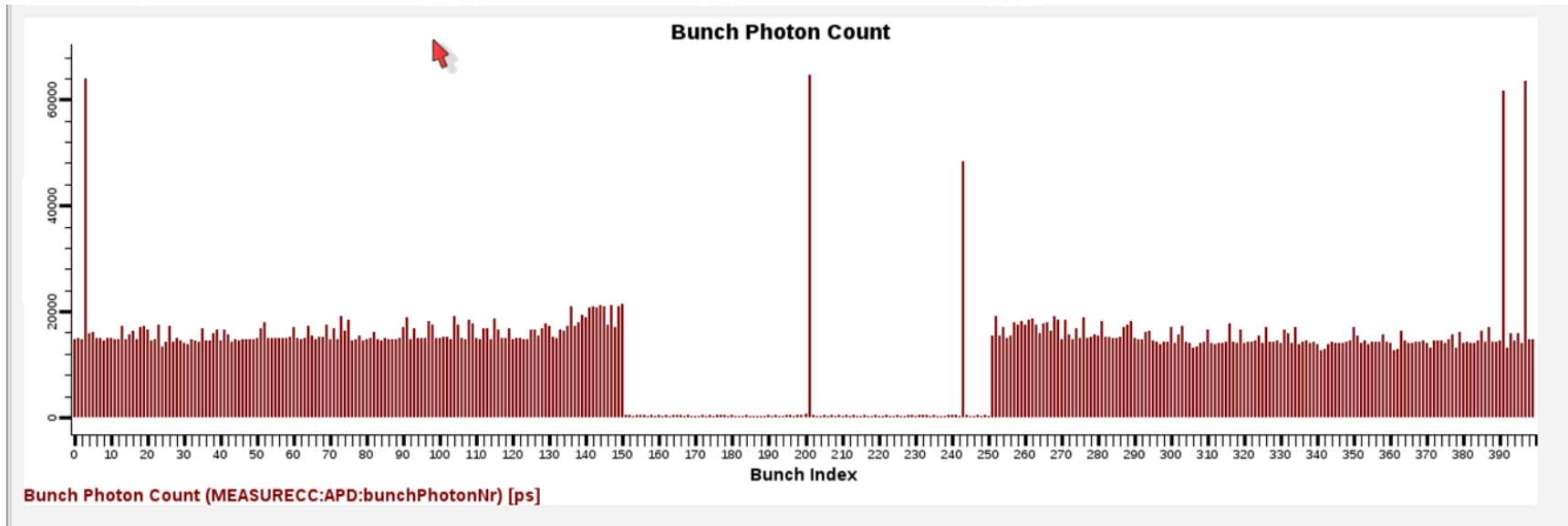
A. Matveenko



- 3rd harmonic, 4 single cell passive cavities, pill-box type
- max. equivalent voltage of 0.65MV
- bunch lengthening in normal operation $\sim 35\%$
- improve Touschek lifetime
- increase transient beam loading
- Robinson-unstable
- can be compensated by stability of main RF, Bunch by Bunch Feedback, natural damping



Typical fill pattern at BESSY II, diagnostic tools



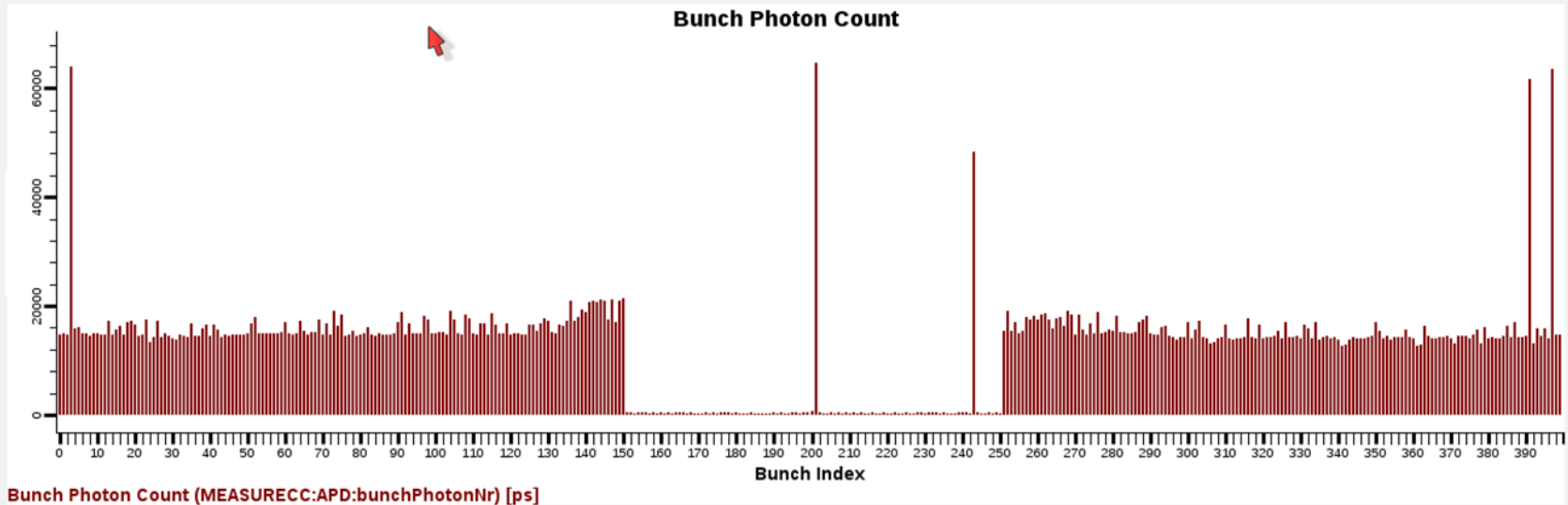
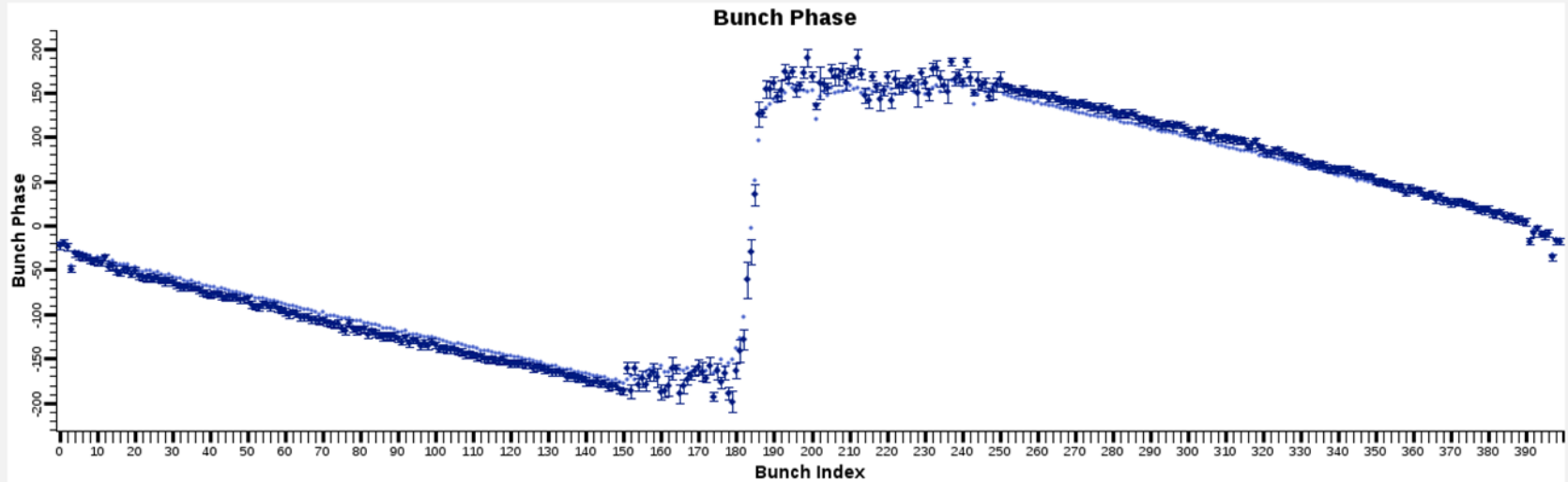
Diagnostic tools available to measure the fill pattern:

- electron beam based (bunch-by-bunch feedback)
- photon beam based (avalanche photodiodes)
- photon beam based (streak-camera)

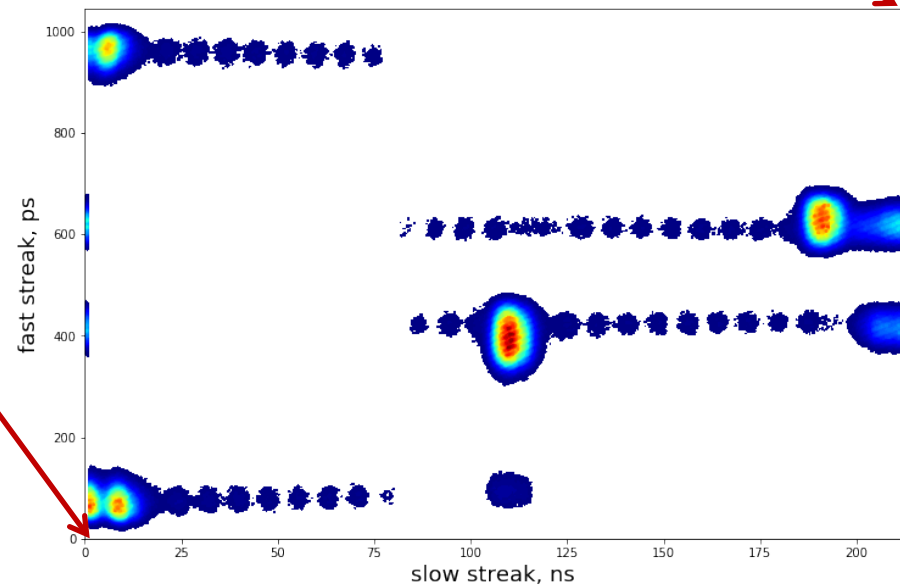
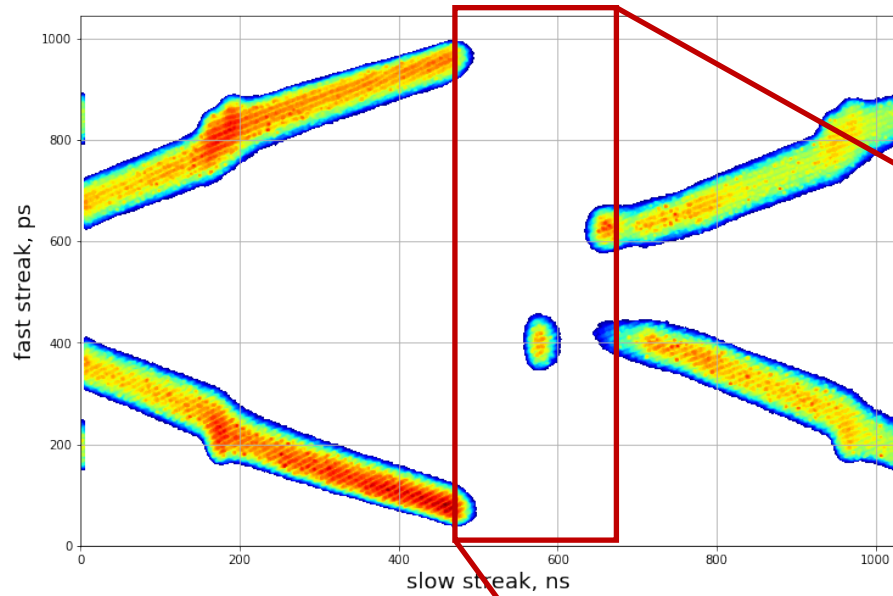
TBL measured with APD, gap filled with low current bunches, 800kV

Bunch Phase derived from Avalanche Photo Diode

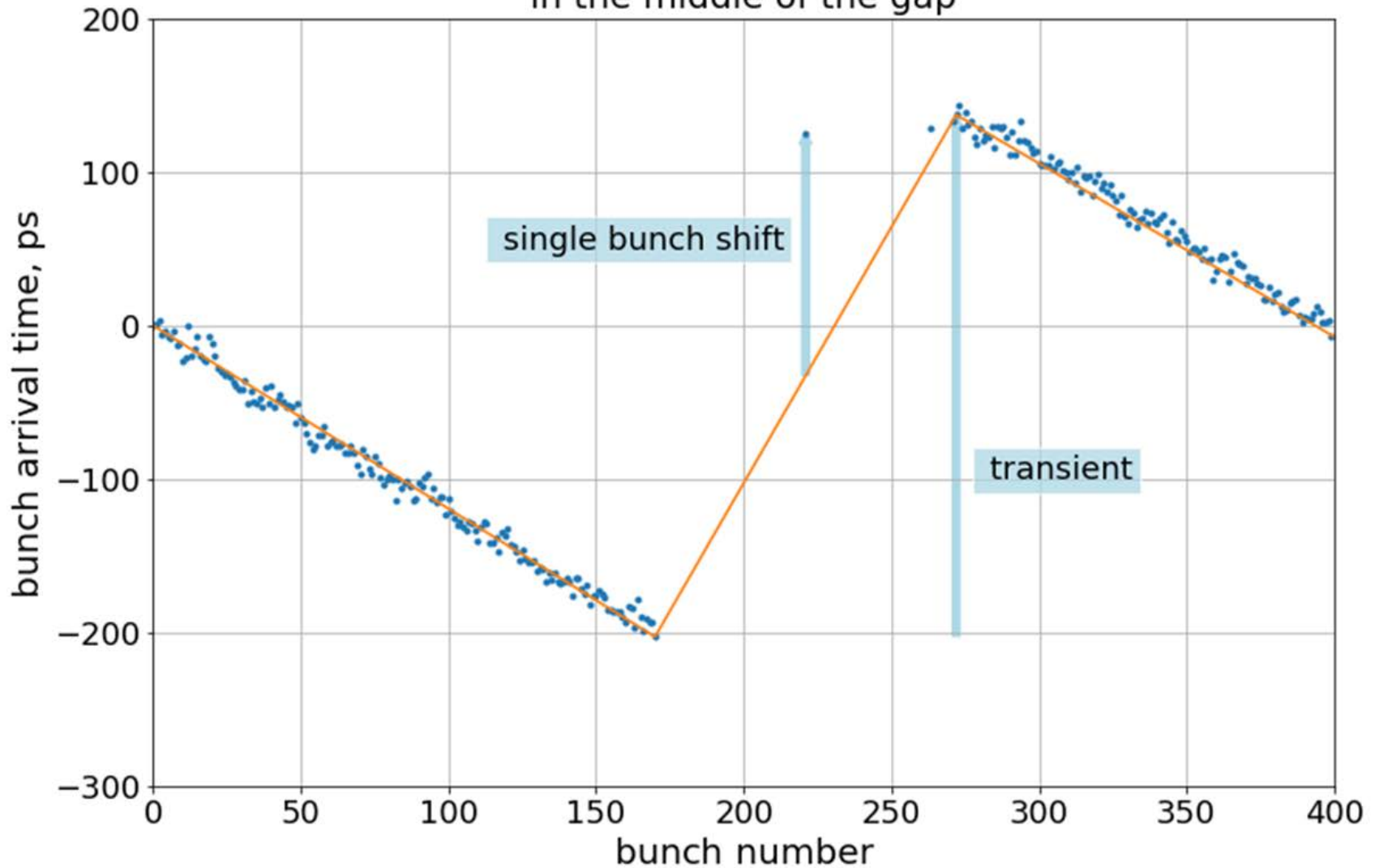
T. Birke (2020-01-17)
BII-Controls/FillPatternApp



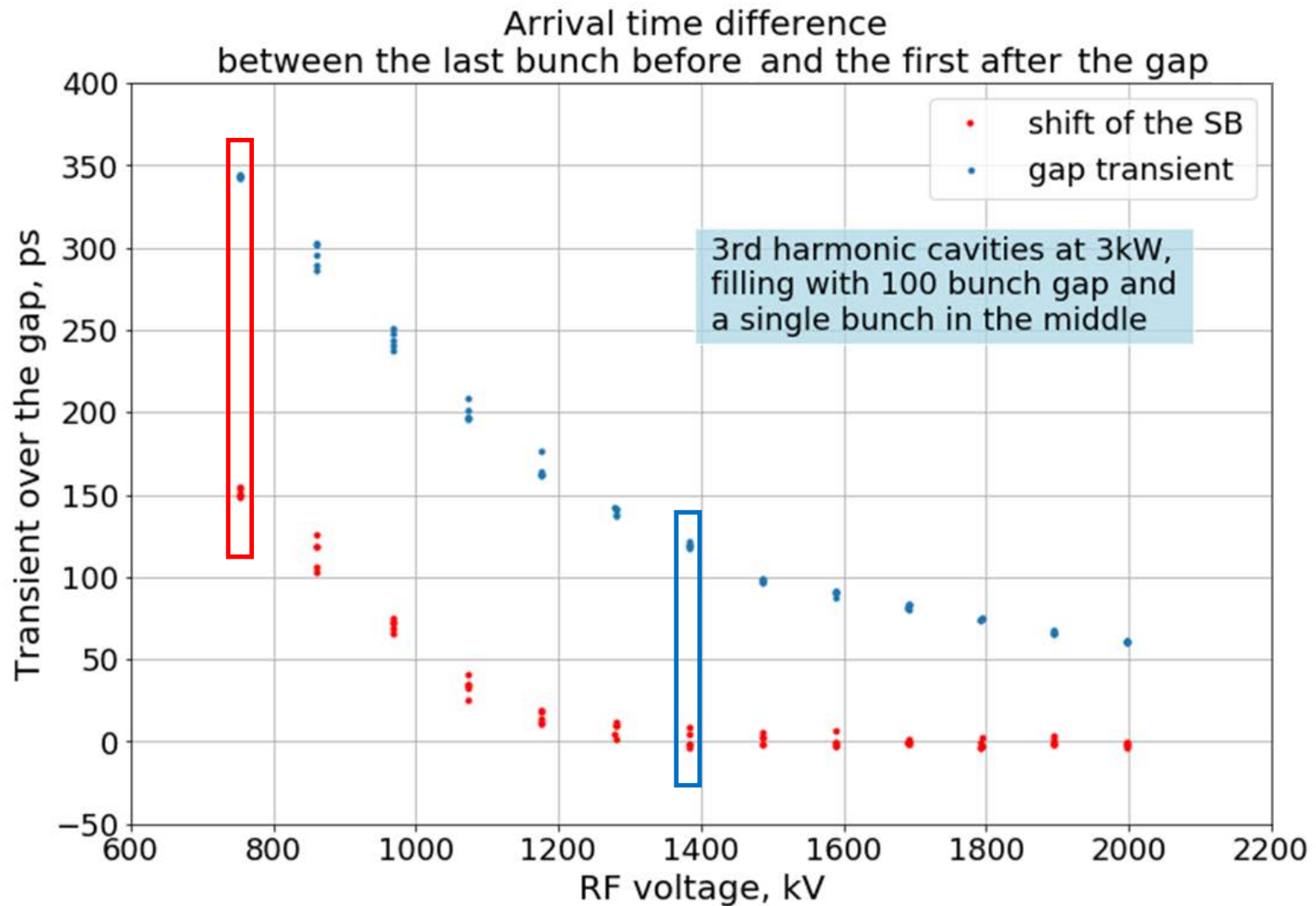
Bunch arrival time in the gap, streak-camera, 800kV



Typical arrival time pattern over a filling
with a 100 bunch gap and a single bunch
in the middle of the gap



Transient beam loading vs. RF voltage amplitude of the main RF



$$I(t) = \sum_{n=1}^h q_n \delta(t - nt_0 - \Delta t_n)$$

- short bunches with individual charges q_n and arrival times Δt_n ($dphi(n) = 2\pi f \Delta t_n$)

```
I_k=zeros(size(t));
for n=1:h
for k=1:h
I_k(k)=I_k(k)+I(n)*exp(-1i*(dphi(n)+2*pi*(n-1)*(k-1)/h));
end
end
```

- if Δt_n were all zeros, $FFT(I(n))$ could be used instead

$U_k = 2 * I_k * Z_k$ - voltages of the harmonics

$$Z(f) = \frac{R_s}{1 + i \cdot \tan \psi}; \tan \psi = Q \left(\frac{f}{f_r} - \frac{f_r}{f} \right) \approx 2Q \frac{\Delta f}{f}$$

- cavity impedance

$$f_k = \frac{k-1}{T}$$

- frequencies of the harmonics

$U(t_n) = \text{ifft}(U_k) * h$ - voltages by arrival of bunches

The modeling is done iteratively. First, all bunches are assumed to have equilibrium phases defined by the main RF

$$\varphi_0 = 3 \cdot \sin^{-1} \frac{\Delta E}{U_{RF}}$$

Then energy loss to the 3rd harmonic cavity is calculated for each bunch. After that the necessary phase shift is calculated, which would compensate the energy loss

$$\Delta\varphi_n = 3 \left(\sin^{-1} \frac{\Delta E + e \cdot \text{Re}(U(t_n))}{U_{RF}} - \sin^{-1} \frac{\Delta E}{U_{RF}} \right)$$

The calculations are repeated with these starting phases again until convergence.

Model parameters:

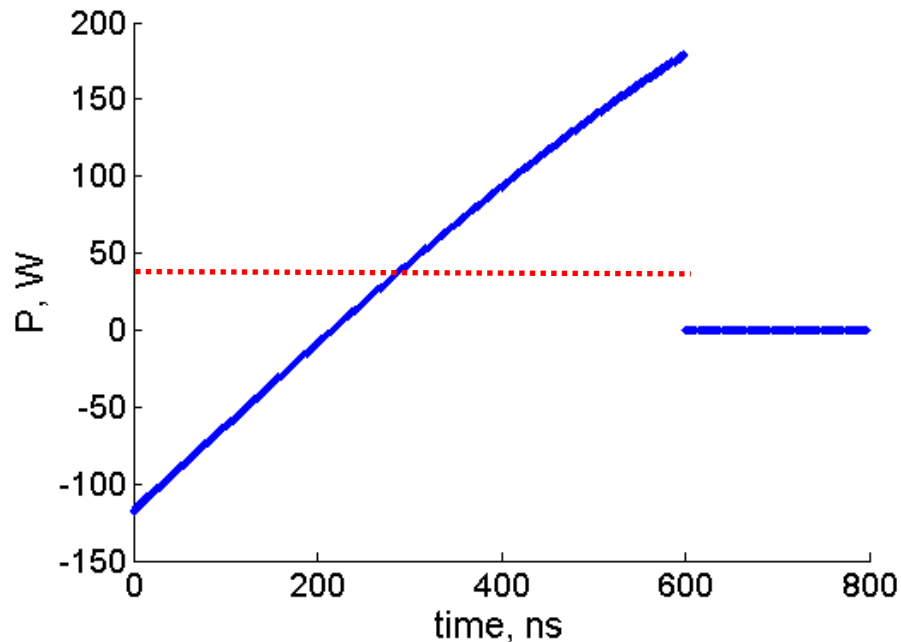
- R/Q , Q – cavity shunt impedance and quality factor
- Δf – detuning
- fill pattern

Consistency check

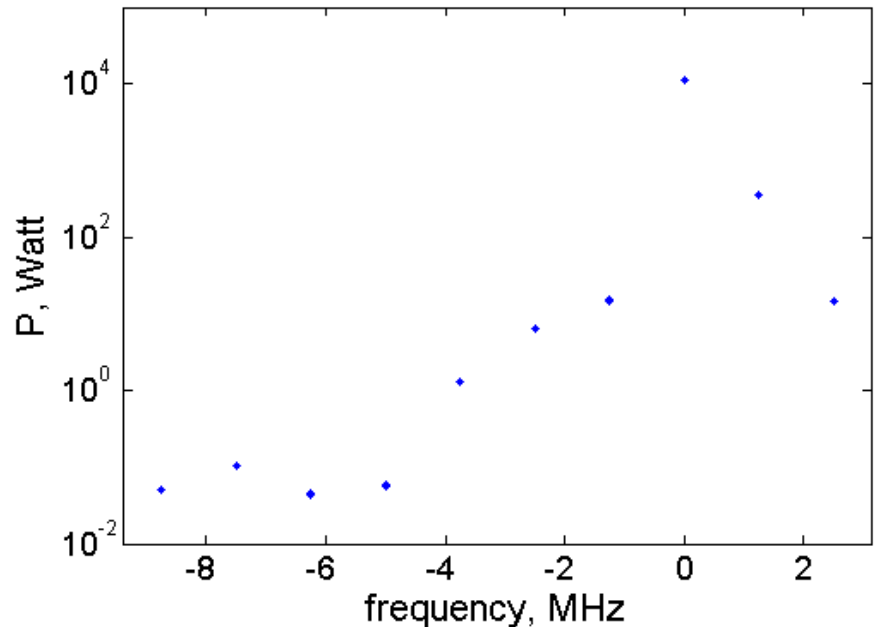
The voltages $U(t_n)$ are complex numbers. Real part of it is the voltage seen by the bunch. Amplitude of it is the voltage which should be used to calculate the power losses in the cavity walls. So, if the cavity is passive, energy conservation demands that all energy lost in the cavity walls be derived from the beam:

$$P = \sum_n \operatorname{Re}(U(t_n)) \cdot q_n = \sum_k \operatorname{Re}(U_k I_k^*)$$

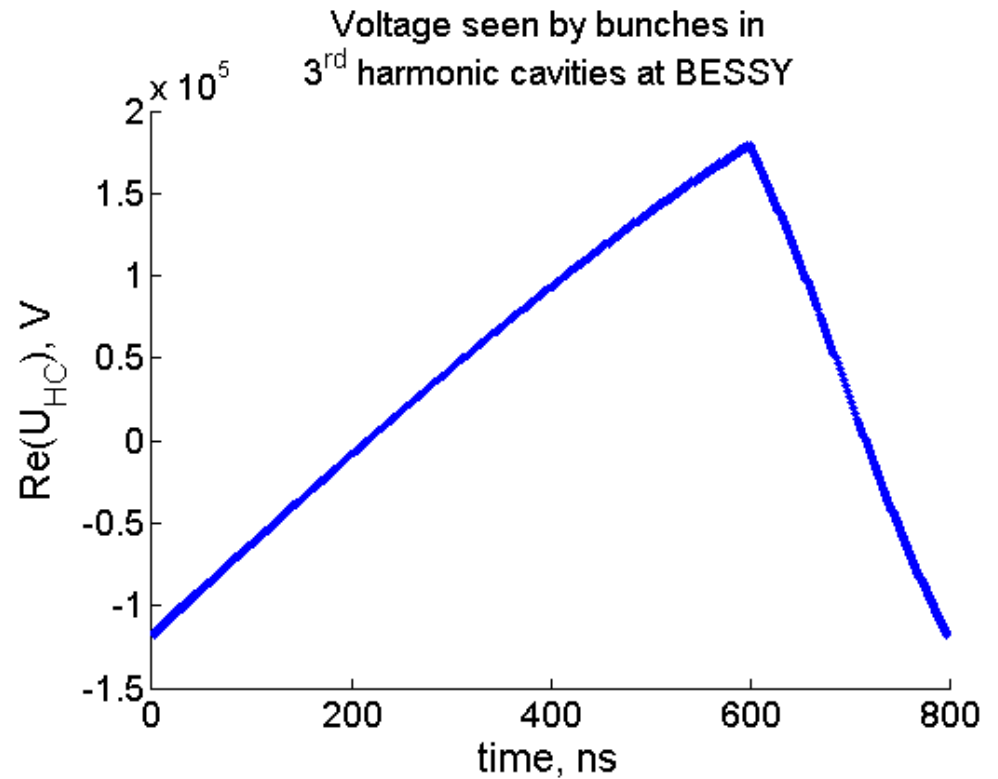
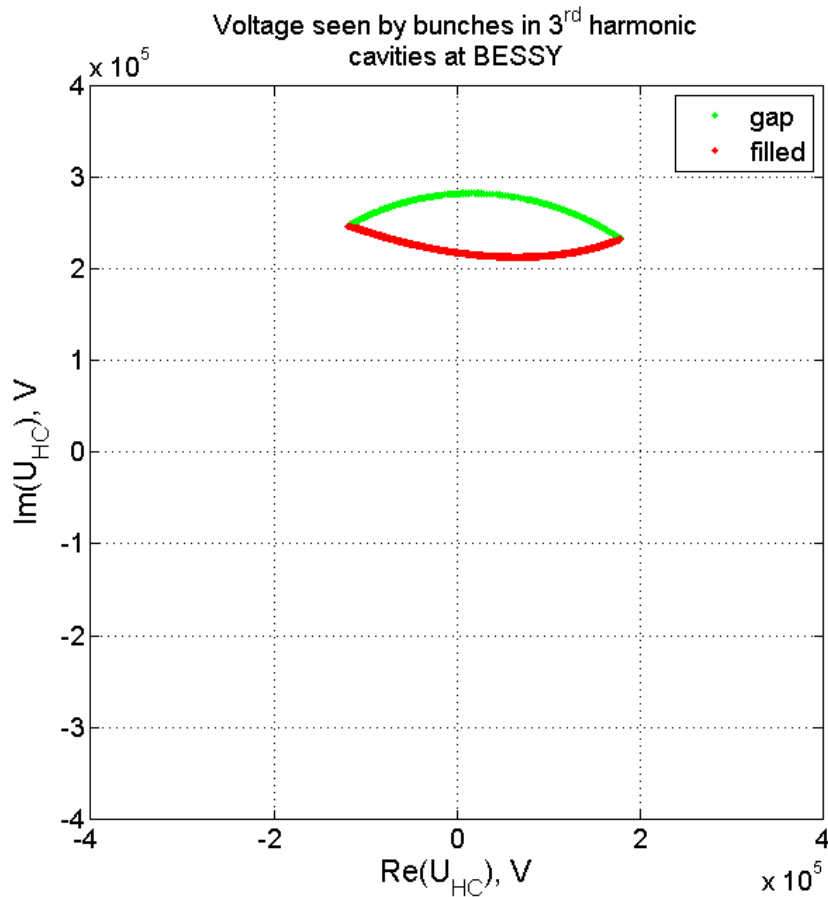
Power taken from cavities per bunch; $\sum P = 11700.182$

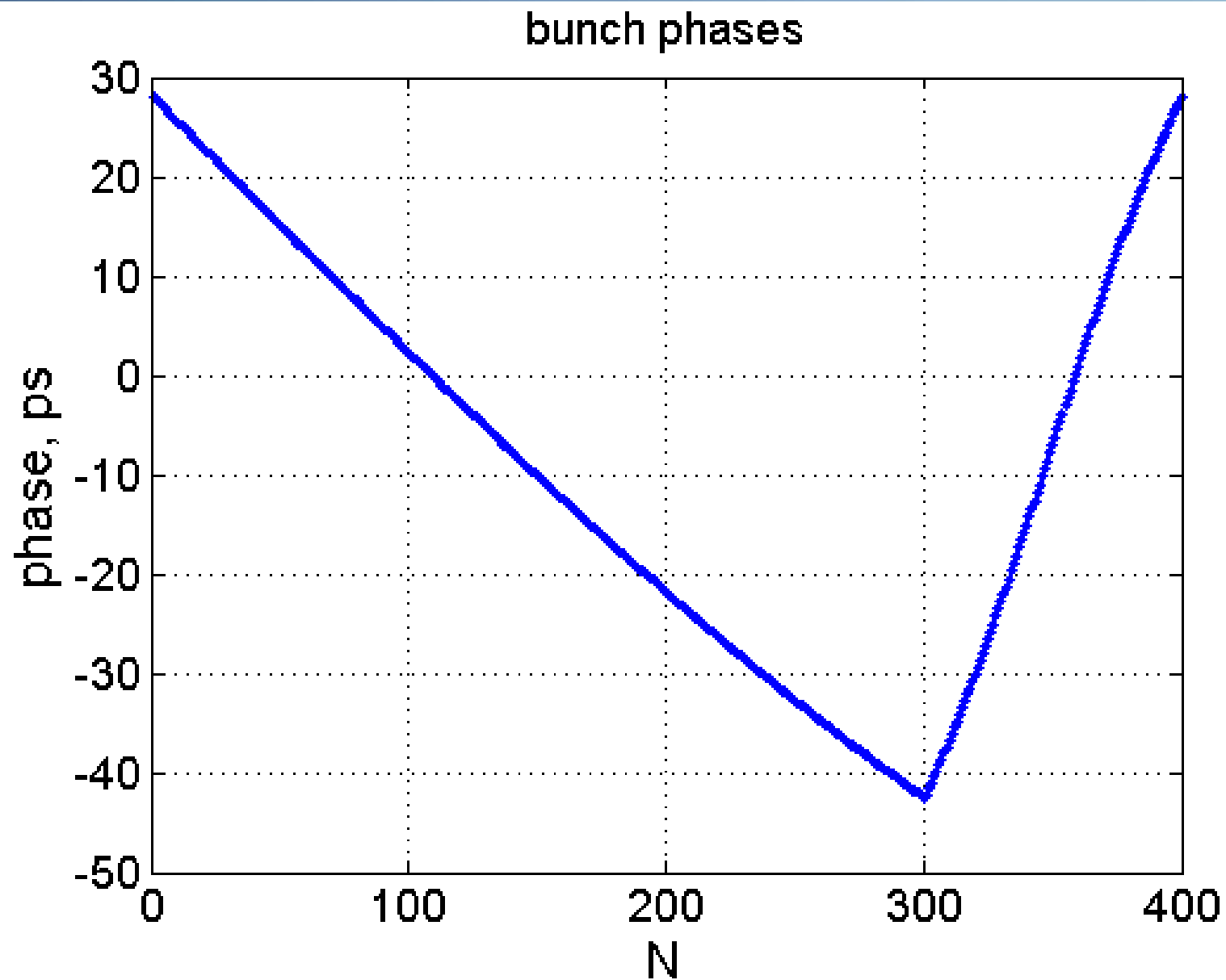


Power taken from cavities per harmonic; $\sum P = 11700.182$

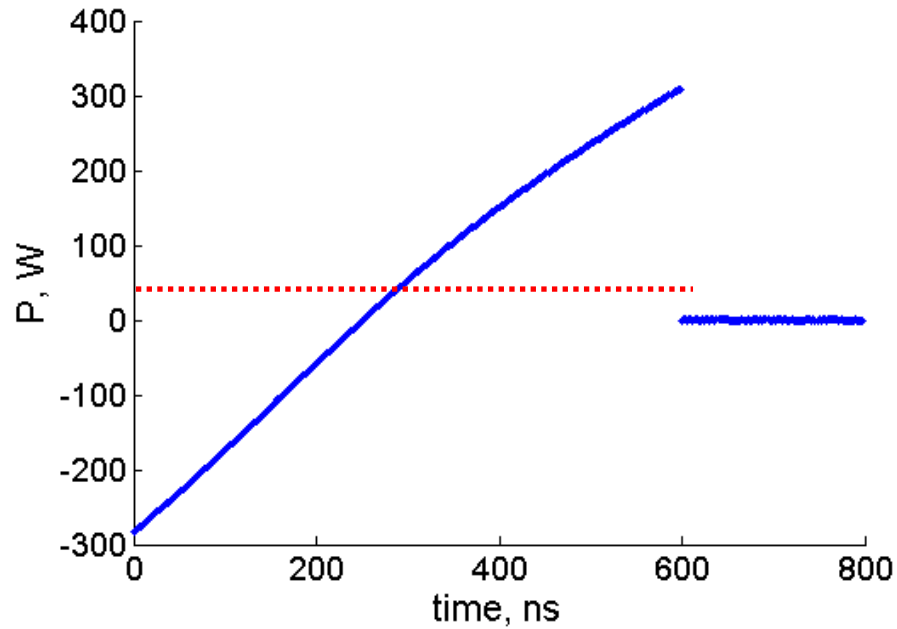


Standard user mode (main RF amplitude 1350kV)

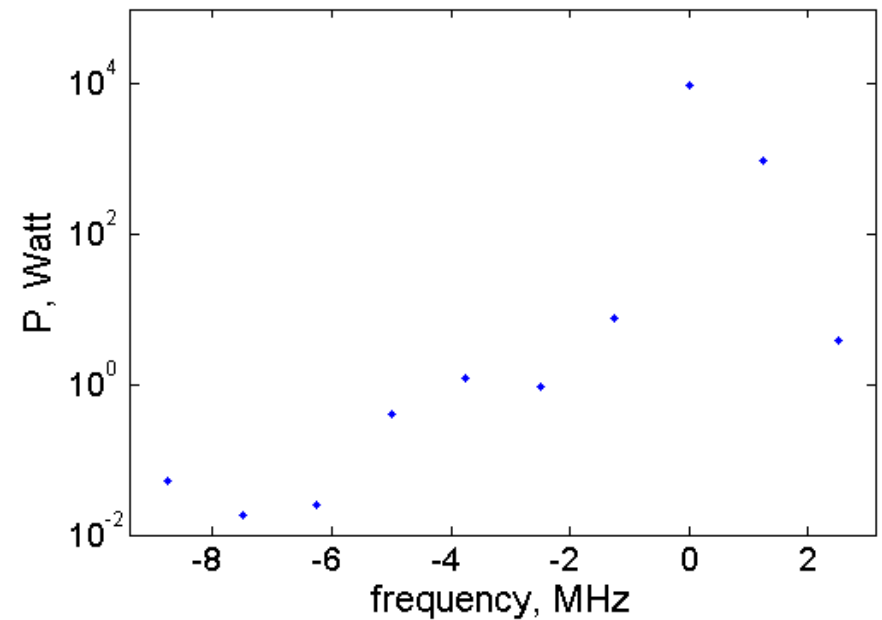




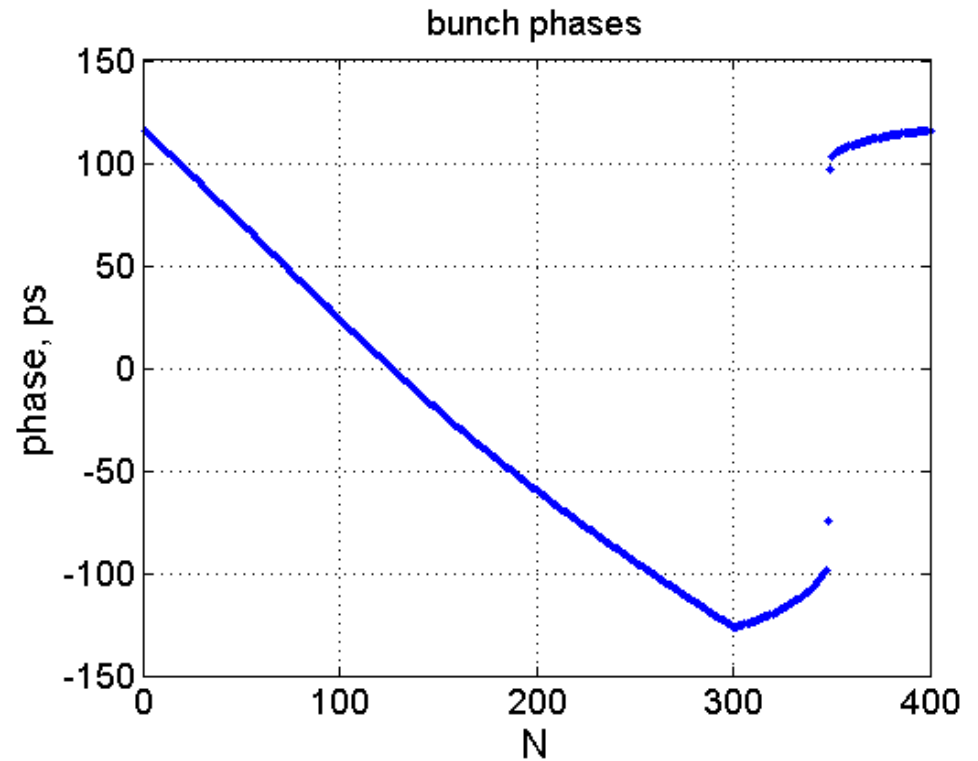
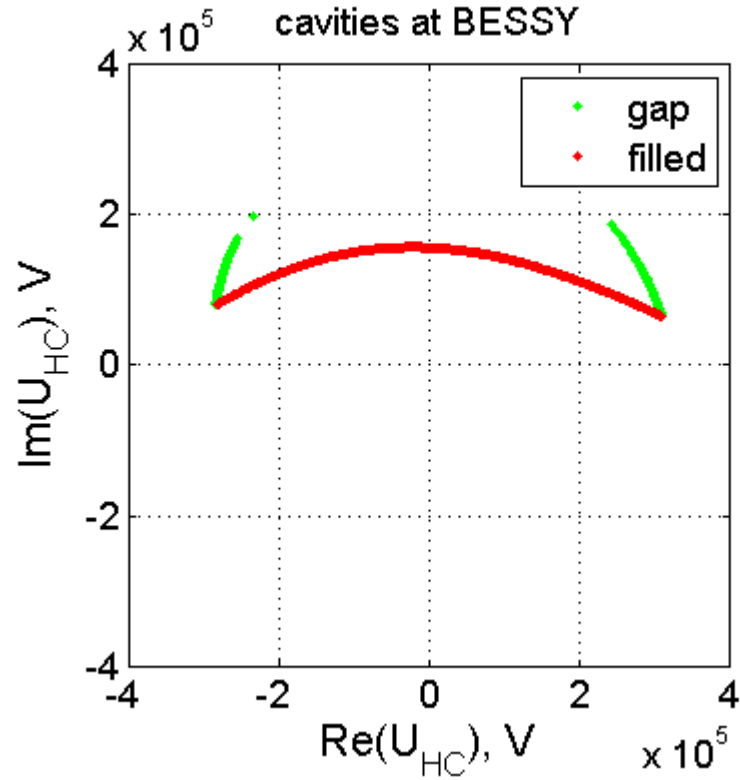
Power taken from cavities per bunch; $\Sigma P = 10878.2529$



Power taken from cavities per harmonic; $\Sigma P = 10878.2529$



Voltage seen by bunches in 3rd harmonic cavities at BESSY



- BESSY II has quite accurate diagnostic tools to measure transient beam loading
- simple MATLAB model gives an insight into the physics behind it
- for better quantitative accuracy effect of the main RF should be taken into account

Thank You for Your attention!

Bunch phases in TRIBs mode at BESSY II (work in progress)

100 %

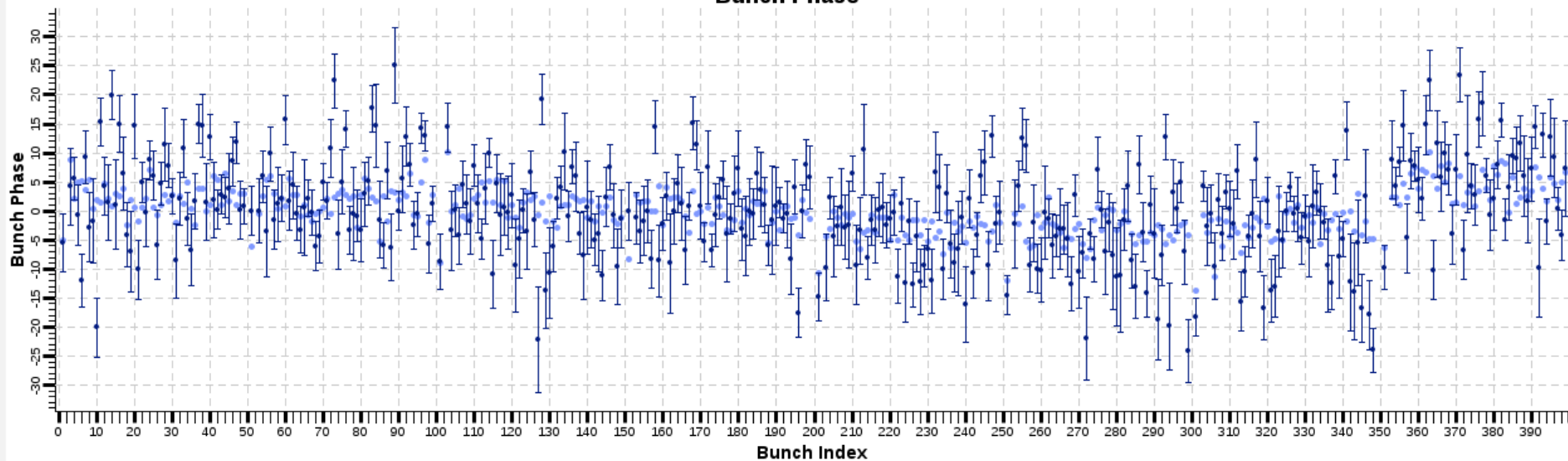


Bunch Phase derived from Avalanche Photo Diode

T. Birke (2020-01-17)

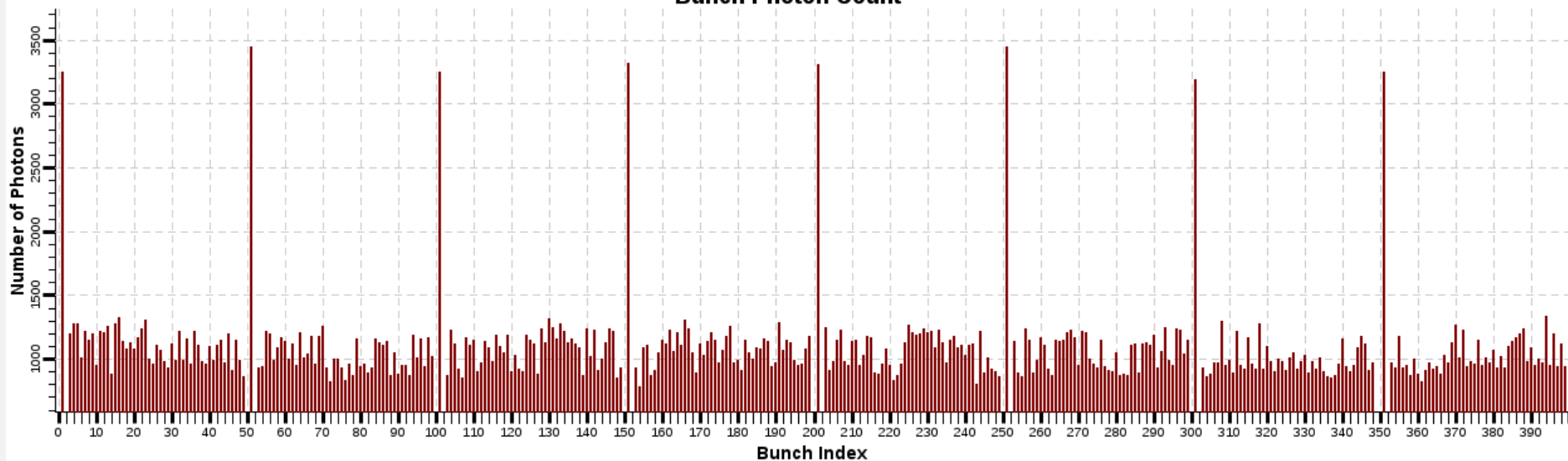
BII-Controls/FillPatternApp

Bunch Phase



Bunch Phase Average (MEASURECC:APD:bunchPhaseAvg) [ps] Bunch Phase (MEASURECC:APD:bunchPhase) [ps]

Bunch Photon Count



Bunch Photon Count (MEASURECC:APD:bunchPhotonNr) [ps]